



N-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^d	Q _g (Typ.)			
100	0.158 at V _{GS} = 10 V	3.8	4.6 nC			
100	0.175 at V _{GS} = 6 V	3.6	4.6110			

FEATURES

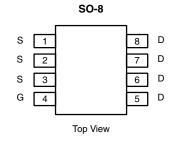
- TrenchFET® Power MOSFET
- 100 % UIS Tested
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912



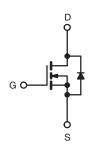
HALOGEN FREE

APPLICATIONS

- High Frequency Boost Converter
- · LED Backlight for LCD TV



Ordering Information: Si4102DY-T1-GE3 (Lead (Pb)-free and Halogen-free)



N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	IGS (T _A = 25 °C	, unless othe	erwise noted)	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V_{DS}	100	V
Gate-Source Voltage		V_{GS}	± 20	V
	T _C = 25 °C		3.8	
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C] ₋	3	
Continuous Diain Current (1) = 130 C)	T _A = 25 °C	- I _D	2.7 ^{a, b}	
	T _A = 70 °C	1	2.1 ^{a, b}	Α
Pulsed Drain Current		I _{DM}	8	
Continuous Source-Drain Diode Current	T _C = 25 °C	lo.	4	
Continuous Source-Diam Diode Current	T _A = 25 °C	- I _S	2 ^{a, b}	
Single Avalanche Current L = 0.1 mH		I _{AS}	6	А
Single Avalanche Energy	L = 0.111111	E _{AS}	1.8	mJ
	T _C = 25 °C		4.8	
Maximum Power Dissipation	T _C = 70 °C	P _D	3	w
Maximum Fower Dissipation	T _A = 25 °C		2.4 ^{a, b}	VV
	T _A = 70 °C		1.5 ^{a, b}	
Operating Junction and Storage Temperatur	e Range	T _J , T _{stg}	- 55 to 150	°C

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R_{thJA}	42	53	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	21	26	7 5/1		

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- c. Maximum under steady state conditions is 85 °C/W.
- d. Based on $T_C = 25$ °C.

Document Number: 69252 S13-0631-Rev. C, 25-Mar-13



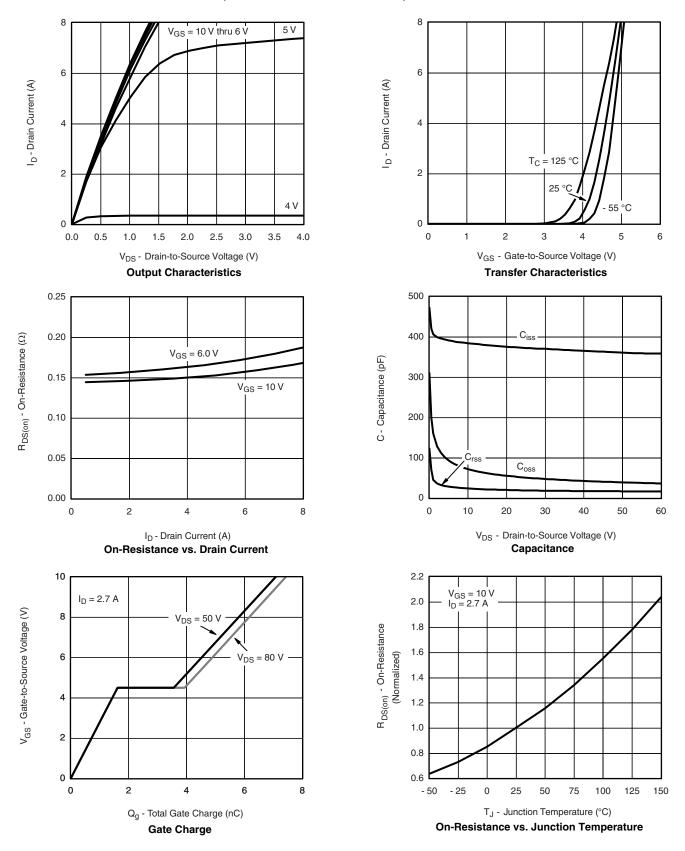
SPECIFICATIONS ($T_J = 25 ^{\circ}\text{C}$,	unless oth	erwise noted)					
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		110		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1D = 230 μΑ		- 7.5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	2		4	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Oata Wallana Busin Oamani		V _{DS} = 100 V, V _{GS} = 0 V	1 10		1	μΑ	
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 100 V, V _{GS} = 0 V, T _J = 55 °C			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	8			Α	
		$V_{GS} = 10 \text{ V}, I_D = 2.7 \text{ A}$			0.158	+	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 6 \text{ V}, I_D = 2.5 \text{ A}$		0.145	0.175	Ω	
Forward Transconductance ^a	g _{fs}	V _{DS} = 10 V, I _D = 2.7 A		7		S	
Dynamic ^b	<u> </u>			I.			
Input Capacitance	C _{iss}			370			
Output Capacitance	C _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		40		pF	
Reverse Transfer Capacitance	C _{rss}			20			
		$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 2.7 \text{ A}$		7.1	11	nC	
Total Gate Charge	Q_g			4.6	7		
Gate-Source Charge	Q_{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 6 \text{ V}, I_{D} = 2.7 \text{ A}$		1.7			
Gate-Drain Charge	Q _{gd}			2			
Gate Resistance	R _g	f = 1 MHz		3		Ω	
Turn-On Delay Time	t _{d(on)}			10	15		
Rise Time	t _r	V_{DD} = 50 V, R_L = 23.8 Ω		10	15		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 2.1 \text{ A}, V_{GEN} = 6 \text{ V}, R_g = 1 \Omega$		10	15	1	
Fall Time	t _f			10	15		
Turn-On Delay Time	t _{d(on)}			10	15	ns	
Rise Time	t _r	V_{DD} = 50 V, R_L = 23.8 Ω		10	15	-	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 2.1 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		12	20		
Fall Time	t _f			10	15	1	
Drain-Source Body Diode Characteristic	s			l	l		
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			4		
Pulse Diode Forward Current	I _{SM}				8	A	
Body Diode Voltage	V_{SD}	$I_S = 2.1 \text{ A}, V_{GS} = 0 \text{ V}$		0.8	1.2	٧	
Body Diode Reverse Recovery Time	t _{rr}			50	80	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	1 04 A 31/4b 400 A / T 07 00		75	120	nC	
Reverse Recovery Fall Time	t _a	$I_F = 2.1 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		28			
Reverse Recovery Rise Time	t _b	-		22		ns	

- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %
- b. Guaranteed by design, not subject to production testing.

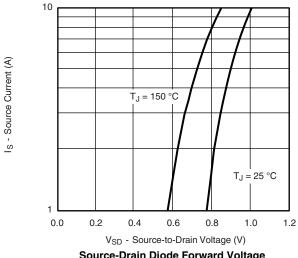
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

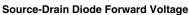


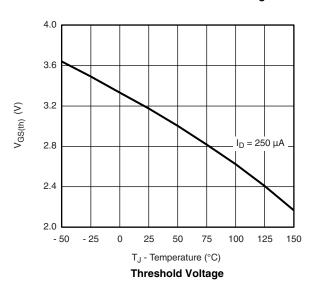
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

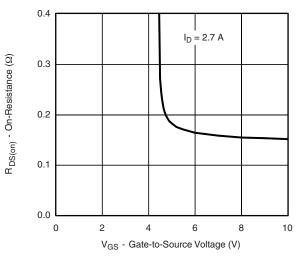


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

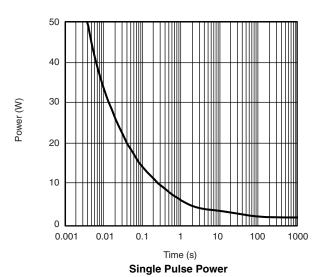


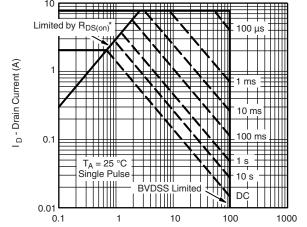






On-Resistance vs. Gate-to-Source Voltage





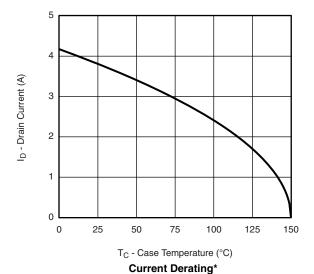
V_{DS} - Drain-to-Source Voltage (V) * V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

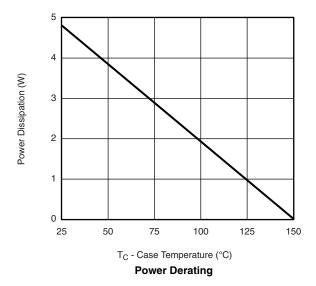
Safe Operating Area, Junction-to-Ambient





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

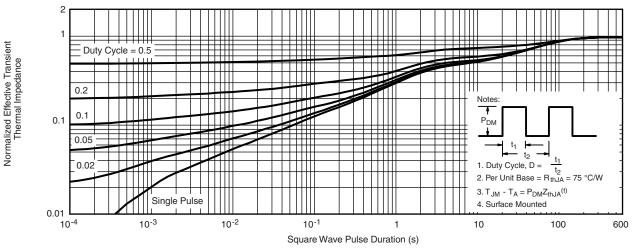




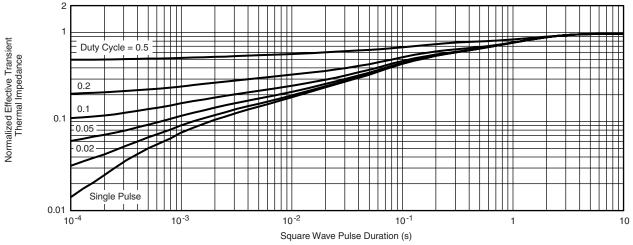
^{*} The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



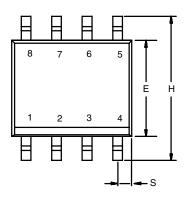
Normalized Thermal Transient Impedance, Junction-to-Ambient



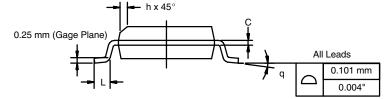
Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?69252.

SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INC	HES	
DIM	Min	Max	Min	Max	
Α	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
Е	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev. I. 11-Sep-06					

DWG: 5498

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RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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APPLICATION NOT

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